Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/720,142	MIYANO ET AL.	
Examiner	Art Unit	
Lefferson A France	2652	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED			
Subclass	Date	Examiner	
294.4	12/12/2005	JAE	
265.9	12/12/2005	JAE	
264.2	12/12/2005	JAE	
	Subclass 294.4 265.9	Subclass Date 294.4 12/12/2005 265.9 12/12/2005	

(INCLUDING SEA	H NOTES ARCH STRATEG	iY)
	DATE	EXMR
EAST (see attached)	12/12/2009	5 JAE